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## Transfer of the sputter technique for deposition of strongly thermochromic VO<sub>2</sub>-based coatings on ultrathin flexible glass to large-scale roll-to-roll device

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#### ABSTRACT

The reversible semiconductor-to-metal transition of vanadium dioxide (VO<sub>2</sub>) makes VO<sub>2</sub>-based coatings a promising candidate for thermochromic smart windows, reducing the energy consumption of buildings. We report on transfer of the sputter technique for deposition of strongly thermochromic  $ZrO_2/W$ -doped  $VO_2/ZrO_2$  coatings on ultrathin (0.1 mm) flexible glass from a laboratory-scale device with three (V, W and Zr) planar magnetron targets to a large-scale roll-to-roll device with two (W-doped V and  $ZrO_2$ ) rotatable magnetron targets. The depositions were performed at a relatively low substrate surface temperature (330–350 °C) and without any substrate bias voltage. The W-doped  $VO_2$  layers were deposited using a reactive high-power impulse magnetron sputtering with a pulsed  $VO_2$  flow control. We compare the process parameters used in both deposition devices and explain the basic principle of this sputter technique using the discharge characteristics measured during a large-scale roll-to-roll deposition. We characterize the design, structure (X-ray diffraction) and optical properties (spectrophotometry and spectroscopic ellipsometry) of the three-layer coatings. The coatings prepared on ultrathin flexible glass using the large-scale roll-to-roll device at a temperature close to 350 °C exhibit a low transition temperature of 22 °C, an integral luminous transmittance over 45% and a modulation of the solar energy transmittance approaching  $VO_2$ -based coatings for future smart-window applications.

#### 1. Introduction

Vanadium dioxide (VO<sub>2</sub>) exhibits a reversible phase transition from a low-temperature monoclinic VO<sub>2</sub>(M1) semiconducting phase to a high-temperature tetragonal VO<sub>2</sub>(R) metallic phase at a transition temperature ( $T_{\rm tr}$ ) of approximately 68 °C for the bulk material [1,2]. This structure transition is accompanied by significant changes in the infrared transmittance, and in electrical and thermal conductivity, which make VO<sub>2</sub>-based films a suitable candidate for numerous applications, such as electronic devices, thermal sensors and energy-saving smart windows with automatically varying solar energy transmission [3–5].

There have been many investigations and much progress in thermochromic  $VO_2$ -based materials in recent years (see, for example, reviews [6–11] and the works cited therein). However, there are still

obstacles impeding their applications to smart windows. To meet the requirements for large-scale implementation on building glass, VO<sub>2</sub>-based coatings should satisfy the following strict criteria simultaneously (see [12] and the works cited therein): a deposition temperature close to 300 °C or lower,  $T_{\rm tr}$  close to 20 °C, a luminous transmittance  $T_{\rm lum} >$  60%, a modulation of the solar energy transmittance  $\Delta T_{\rm sol} >$  10%, long-time environmental stability, and a more appealing color than usual yellowish or brownish colors in transmission (smart window as seen from the inside). Moreover, a cost-effective technique for fast deposition of large-area thermochromic VO<sub>2</sub>-based coatings for future smartwindow applications should be developed.

Magnetron sputter deposition with its versatility and the potential of scaling up to large substrate sizes, is arguably the most important preparation technique of thermochromic  $VO_2$ -based coatings [11,13,14].

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In our recent paper [12], we reported on high-performance three-layer thermochromic ZrO $_2$ /V $_{0.982}$ W $_{0.018}$ O $_2$ /ZrO $_2$  coatings prepared on soda-lime glass using a pulsed magnetron sputtering at a relatively low substrate surface temperature  $T_{\rm s}=330$  °C and without any substrate bias voltage. The thermochromic V $_{0.982}$ W $_{0.018}$ O $_2$  layers were deposited by a controlled high-power impulse magnetron sputtering (HiPIMS) of a V target, combined with a simultaneous pulsed dc magnetron sputtering of a W target to reduce the transition temperature to  $T_{\rm tr}=20$ –21 °C, in an argon-oxygen gas mixture. The ZrO $_2$ /V $_{0.982}$ W $_{0.018}$ O $_2$ /ZrO $_2$  coatings exhibited  $T_{\rm lum}$  up to 50% at  $\Delta T_{\rm sol}$  above 10% for a V $_{0.982}$ W $_{0.018}$ O $_2$  layer thickness of 69 nm. Let us recall that the first low-temperature deposition of thermochromic VO $_2$  films using HiPIMS, but with a substrate bias voltage, was presented in [15].

Our preceding paper [16] dealt with the optimization of the deposition technique for preparation of three-layer thermochromic  $\rm ZrO_2/V_{1.x}W_xO_2/ZrO_2$  coatings on ultrathin flexible glass (UFG) and standard glass in large-scale deposition systems. A high maximum target power density (spatially averaged over the total target area) in a pulse during the HiPIMS of the V target [12] was decreased three times to 1.4 kWcm $^{-2}$  at almost the same deposition-averaged target power density of 13.5 Wcm $^{-2}$ . To avoid atmospheric contamination and to reduce the total deposition time, the preparation of the  $\rm ZrO_2/V_{0.984}W_{0.016}O_2/ZrO_2$  coatings was performed in the same vacuum chamber without venting it to the atmosphere between the depositions of individual layers.

In the present paper, we report on transfer of this sputter technique for deposition of strongly thermochromic ZrO2/W-doped VO2/ZrO2 coatings on ultrathin (0.1 mm) flexible glass from the laboratory-scale device with three (V, W and Zr) planar magnetron targets [16] at the University of West Bohemia (UWB) to a large-scale roll-to-roll device with two (W-doped V and ZrO2) rotatable magnetron targets at the Fraunhofer Institute for Organic Electronics, Electron Beam and Plasma Technology FEP (FEP). The UFG was introduced to the market recently [17] as an alternative both to thick (rigid) glass sheets and to flexible polymer substrates. Its material properties are similar to those of rigid glass, but the thickness is much lower, ranging from 0.2 mm down to 0.02 mm [18]. In contrast to most polymers, the UFG is stable at much higher temperatures (even above 500 °C). Therefore, it can be used as a substrate for deposition of thermochromic VO2-based coatings. Bendability of the UFG enables its high-volume processing using a roll-to-roll deposition device with magnetron sputter sources [17-19]. Because of the low weight of the UFG, this opens up the possibility for new smartwindow applications of thermochromic VO<sub>2</sub>-based coatings, such as retrofitting of existing low-efficiency glass windows [20] and the manufacturing of new high-efficiency insulated glass units with multiple functionalities (for example, a combination with electrochromic coatings).

#### 2. Experimental details

#### 2.1. Coating preparation

The basic characteristics of both devices used for depositions of  $\rm ZrO_2/W\text{-}doped\ VO_2/ZrO_2$  coatings on 0.1 mm thick flexible glass

(Nippon Electric Glass Co., Ltd.) substrate without any substrate bias voltage in argon-oxygen gas mixtures are given in Table 1.

#### 2.1.1. Laboratory-scale device

The ZrO<sub>2</sub>/V<sub>0.984</sub>W<sub>0.016</sub>O<sub>2</sub>/ZrO<sub>2</sub> coating was prepared at the UWB in an ultra-high vacuum multi-magnetron sputter device (ATC 2200-V AJA International Inc.) equipped by three unbalanced magnetrons with planar V, W and Zr targets at the argon partial pressure  $p_{\rm ar}=1$  Pa. The values of  $p_{\rm ar}$  and of  $p_{\rm tot}=p_{\rm ar}+p_{\rm ox}$ , where  $p_{\rm ox}$  is the oxygen partial pressure in the chamber, were measured at the chamber wall using a high-stability capacitance manometer (Baratron, Type 127, MKS) with an accuracy much better than 1%.

The V<sub>0.984</sub>W<sub>0.016</sub>O<sub>2</sub> layer was deposited by controlled HiPIMS of a V target, combined with a simultaneous pulsed dc magnetron sputtering of a W target, at the substrate surface temperature  $T_s = 330$  °C. The argon flow rate was 60 sccm corresponding to  $p_{ar} = 1$  Pa, while the total oxygen flow rate,  $\Phi_{ox}$ , in two to-substrate  $O_2$  inlets, injecting oxygen in front of the V sputtered target, was not fixed but alternating between 1.45 sccm and 1.85 sccm (see Table 2). The moments of switching of the  $\Phi_{\rm ox}$  pulses from one value to the other were determined during the deposition by a programmable logic controller using a pre-selected critical value of the discharge current on the V target. This simple process control, explained in [16], makes it possible to deliver a high power into discharge pulses without arcing on the V target surface and thus, to utilize exclusive benefits of the HiPIMS discharges in the preparation of crystalline thermochromic VO2-based layers on unbiased nonconductive substrates at relatively low  $T_s$  [21,22]. The magnetron with the V target was driven by a unipolar high-power pulsed dc power supply (TruPlasma Highpulse 4002, TRUMPF Huettinger). The voltage pulse duration was 80 µs at a repetition frequency of 625 Hz (duty cycle of 5%) and the deposition-averaged target power density was 13.5 Wcm<sup>-2</sup>. The magnetron with the W target was driven by a unipolar pulsed dc power supply (IAP-1010 EN Technologies Inc.). The voltage pulse duration was 16 µs at a repetition frequency of 5 kHz (duty cycle of 8%) and the deposition-averaged target power density was  $35 \text{ mWcm}^{-2}$ .

Both the bottom and the top  $\rm ZrO_2$  layer were deposited by reactive pulsed dc magnetron sputtering onto substrates without any external heating ( $T_{\rm s} < 60$  °C). The oxygen partial pressure was 0.12 Pa (oxide mode) at  $\Phi_{\rm ox} = 9$  sccm. The magnetron with the Zr target was driven by an asymmetric bipolar pulsed dc power supply (TruPlasma Bipolar 4010, TRUMPF Huettinger). The negative-voltage pulse duration was 6.25  $\mu$ s at a repetition frequency of 80 kHz (duty cycle of 50%) and the average target power density was 12.6 Wcm $^{-2}$  in these negative pulses. Further details on the deposition process can be found in [16].

#### 2.1.2. Large-scale roll-to roll device

The  $\rm ZrO_2/W$ -doped  $\rm VO_2/ZrO_2$  coatings were prepared at the FEP in a large-scale roll-to-roll device (FOSA LabX 330 Glass, Von Ardenne GmbH) equipped by two magnetrons with W-doped (1.5 at.%, resulting in almost the same x characterizing the  $\rm V_{1-x}W_xO_2$  layer deposited on the used roll substrate) V, denoted as V-W from now on, and  $\rm ZrO_2$  rotatable (15 rpm) targets in two individual sputter chambers (see Fig. 1 and Table 1). Dual-anode magnetron configurations [23] were used to

Table 1
Basic characteristics of the laboratory-scale device and the large-scale roll-to-roll device used for depositions of  $ZrO_2/W$ -doped  $VO_2/ZrO_2$  coatings at the University of West Bohemia (UWB) and at the Fraunhofer FEP (FEP), respectively. Here, d and l is the diameter and length, respectively.

	Laboratory device (UWB)	Roll-to-roll device (FEP)
Vacuum chamber	d = 560  mm, l = 430  mm	d = 2760  mm, l = 1170  mm
Targets	Planar V, W and Zr	Rotatable W-doped (1.5 at.%) V
	(d = 50  mm in all cases)	$(d=139 \text{ mm}, l=665 \text{ mm}) \text{ and } \text{ZrO}_2$
		(d = 139  mm, l = 679  mm)
Substrate	Fixed sheeth (25 $\times$ 50 mm <sup>2</sup> )	Moving roll (300 $\times$ 20 000 mm <sup>2</sup> )
	on rotating (20 rmp) holder	
Target-to-substrate	145 mm	80 mm
distance		

#### Table 2

Process parameters during the depositions of the thermochromic  $V_{0.984}W_{0.016}O_2$  layer using a controlled high-power impulse magnetron sputtering (HiPIMS) of a V target, combined with a simultaneous pulsed dc magnetron sputtering of a W target, at the University of West Bohemia (UWB) and the thermochromic W-doped  $VO_2$  layer using a controlled HiPIMS of a rotatable W-doped (1.5 at.%) V target at the Fraunhofer (FEP), see Table 1. Here,  $P_{av}$  is the deposition-averaged target power,  $P_{max}$  is the maximum target power in a pulse,  $t_{on}$  is the (negative) voltage pulse duration,  $f_T$  is the repetition frequency ( $f_T = 1/T_p$  where  $T_p$  is the pulse period),  $t_{on}/T_p$  is the duty cycle,  $p_{ar}$  is the argon partial pressure,  $p_{ox}$  is the oxygen partial pressure,  $p_{ox}$  is the oxygen flow rate.

Device	Target	$P_{\mathrm{av}}$	$P_{\max}$	ton	$f_{\rm r}$	$t_{\rm on}/T_{\rm p}$	$p_{\rm ar}$	$p_{ m ox}$	$\Phi_{ m ar}$	$\Phi_{ m ox}$
		(kW)	(kW)	(μs)	(Hz)	(%)	(Pa)	(Pa)	(sccm)	(sccm)
UWB	V	0.27	27.49	80	625	5.00	1.00	0.02-0.05	60	1.45-1.85
	W	$0.69 \times 10^{-3}$	$16.02\times10^{-3}$	16	5000	8.00	1.00	0.02-0.05	60	1.45-1.85
FEP	V-W	6.00	276.45	70	750	5.25	0.20	0.00-0.02	250	0-50

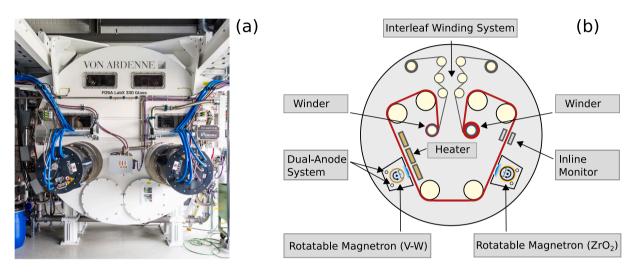


Fig. 1. (a) Photo and (b) schematic diagram of the large-scale roll-to-roll device used for depositions of ZrO<sub>2</sub>/W-doped VO<sub>2</sub>/ZrO<sub>2</sub> coatings at the Fraunhofer FEP (see Table 1).

minimize arcing on the sputtered targets and to avoid a "disappearing anode" effect. The pressures during the depositions were measured using two (one for each sputter chamber) capacitance manometers (Baratron, Type 627D, MKS).

The UFG substrate was guided between two winders. Both the bottom and the top  $\rm ZrO_2$  layer were deposited using the magnetron with the  $\rm ZrO_2$  target during the UFG substrate motion with a band speed of 0.15 m/min from the right-side winder to the left-side winder, as viewed from the front of the device. The W-doped VO $_2$  layer was deposited using the magnetron with the V-W target during the UFG substrate motion with a band speed of 0.10 m/min from the left-side winder to the right-side winder.

The W-doped VO<sub>2</sub> layer was deposited by controlled HiPIMS of the V-W target at a substrate surface temperature close to 350 °C. This  $T_{\rm s}$ value was estimated on the basis of the evaluations presented for the same device recently [19]. The argon flow rate was 250 sccm corresponding to  $p_{ar} = 0.20$  Pa, while the total  $\Phi_{ox}$  in eight  $O_2$  inlets, placed in front of and along the sputtered V-W target and oriented to the substrate, was 0 or 50 sccm (see Fig. 2 and Table 2). The moments of switching of the  $\Phi_{ox}$  pulses from one value to the other were determined during the deposition by a programmable logic controller, developed at the UWB, which was adapted (modification of analog inputs and outputs, and optimization of the controller software interface) to the large-scale rollto-roll device at the FEP. In contrast to the aforementioned deposition of the  $V_{0.984}W_{0.016}O_2$  layer at the UWB [16], a pre-selected critical value of  $p_{\rm ox}$  (as in [21,22]) determined switching of the  $\Phi_{\rm ox}$  during the depositions of the W-doped  $VO_2$  layers with a fixed  $p_{ar}=0.20$  Pa at the FEP. When the increasing monitored  $p_{tot}$  reached the critical value  $(p_{\rm tot})_{\rm cr}=0.21$  Pa (marked by a dashed line in Fig. 2a), the process controller sent a signal to the input of the O2 mass flow controller to switch off the oxygen flow  $\Phi_{ox} = 50$  sccm. When the decreasing monitored  $p_{tot}$  reached the critical value ( $p_{tot}$ )<sub>cr</sub> = 0.21 Pa again, the process controller sent a signal to the O<sub>2</sub> mass flow controller to switch on the oxygen flow  $\Phi_{ox} = 50$  sccm. Fig. 2a shows a delayed opening and fast closing of the O<sub>2</sub> mass flow controller. The magnetron with the V-W target was driven by a high-power pulsed dc power supply (20 kW HIP-V, Ingeniería Viesca, S.L.). The voltage pulse duration was 70  $\mu$ s at a repetition frequency of 750 Hz (duty cycle of 5.25%) and the deposition-averaged target power was 6 kW (see Table 2). The corresponding deposition-averaged target power density (spatially averaged over the total target area being sputtered at a given time) was approximately 10 Wcm<sup>-2</sup>.

The basic principle of the used sputter technique is presented in Fig. 2, which shows the time evolution of the magnetron voltage,  $U_{\rm d}(t)$ , and the target current,  $I_{\rm d}(t)$ , during a deposition of the W-doped VO<sub>2</sub> layer. As can be seen in Fig. 2, the waveforms of  $U_{\rm d}(t)$  and  $I_{\rm d}(t)$  oscillate during the deposition in a dependence on the value of  $p_{\rm ox}$  in the discharge, being in the range from 0 to 0.02 Pa (see Fig. 2a). The corresponding maximum target currents in a pulse were 470 A and 570 A, respectively, at almost the same magnetron voltage of 485 V (see Fig. 2b). The much higher values of  $I_{\rm d}(t)$  at the highest  $p_{\rm ox}$ , leading to a maximum target power of 276 kW in a pulse, can be explained [22]: (i) by a significantly enlarged flux of the  $O_2^+$  and  $O^+$  ions, arising in front of the partly oxidized V-W target at an increased local oxygen partial pressure, and (ii) by an increased secondary-electron emission yield of the V-W target with a larger compound coverage, particularly for the impacting  $O_2^+$  and  $O^+$  ions.

The advantages of the used pulsed O<sub>2</sub> flow control are: (i) very high process stability (no problems with inertia of the inlet system, delay of valves and sensors, and hysteresis effects) as the controller does not try to keep one value but allows for a pre-selected interval of an output variable in accordance with the control-theory literature dealing with

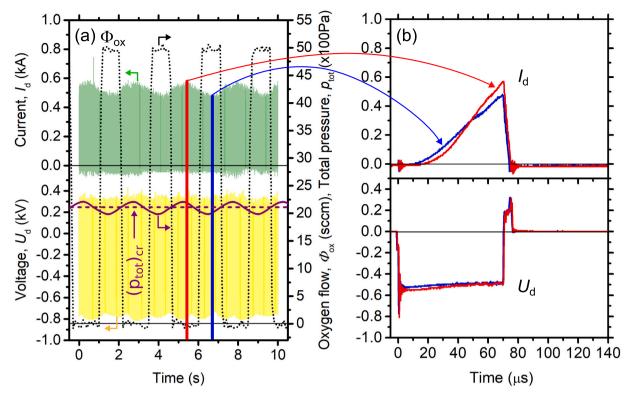


Fig. 2. (a) The contours of the shaded areas represent the magnetron voltage,  $U_d$ , and the target current,  $I_d$ , during a deposition of the W-doped VO<sub>2</sub> layer using the large-scale roll-to-roll device (Tables 1 and 2). A pre-selected critical value of the total pressure  $(p_{tot})_{cr} = 0.21$  Pa determining the switching between the oxygen flow rate  $\Phi_{ox} = 0$  and 50 sccm is marked by a dashed line. The  $\Phi_{ox}$  values measured at the output from the O<sub>2</sub> mass flow controller are marked by dotted lines. (b) Time evolution of the  $U_d$  and  $I_d$  values at the rotatable V-W magnetron target during the pulses related to the minimum and maximum values of the oxygen partial pressure.

the control of non-linear systems [24], (ii) simplicity, as no additional measurement devices (such as a plasma emission monitoring system, mass spectrometer or Lambda sensor) are needed, and (iii) applicability to large-area industrial coaters as a multi-segment  $\rm O_2$  injection control can be used.

As can be seen in Fig. 2, short-lived high positive  $U_{\rm d}$  overshoots (over 300 V) with the corresponding large electron fluxes drawn from the plasma onto the target (see the negative values of  $I_{\rm d}$ ) can be identified after the negative  $U_{\rm d}$  pulses. These electron fluxes quickly neutralize the positive charge accumulated on non-conducting parts of the target surface during negative  $U_{\rm d}$  pulses. As a consequence, the arcing on the target surface is minimized. The  $I_{\rm d}$  oscillations appearing at the very beginning of the negative  $U_{\rm d}$  pulses are oscillating capacity currents, accompanied by the voltage oscillations, in the power supply circuit caused by fast negative voltage transitions on the power supply.

Both the bottom and the top ZrO<sub>2</sub> layer were deposited by unipolar pulsed dc magnetron sputtering onto the substrate without an external heating. The total pressure was 0.40 Pa at  $\Phi_{ar}=250$  sccm and  $\Phi_{ox}=8$  sccm. The magnetron with the ZrO<sub>2</sub> target was driven by a dc power supply (Type 20 k, TLU GmbH) combined with a pulse unit (UBS-C2, Fraunhofer FEP). The voltage pulse duration was 16  $\mu s$  at a repetition frequency of 50 kHz (duty cycle of 80%) and the deposition-averaged target power was 6 kW.

To support the crystallinity of the W-doped  $VO_2$  layers and to improve the uniformity of the coatings, a post annealing of the three-layer  $ZrO_2/W$ -doped  $VO_2/ZrO_2$  coatings was carried out at an estimated temperature close to 320 °C, when the coatings passed along the radiation heater near the sputter chamber with the V-W magnetron (see Fig. 1) after the deposition of the top  $ZrO_2$  layer. The turn-on of this heater had only a slight effect on the  $T_s$  value during the deposition of the top  $ZrO_2$  layer using the  $ZrO_2$  magnetron.

#### 2.2. Coating characterization

The thickness and room-temperature (23 °C) optical constants (refractive index, n, and extinction coefficient, k) of individual layers were measured by spectroscopic ellipsometry using the J.A. Woollam Co. Inc. VASE instrument. The precision was enhanced by dividing the analysis into two steps: (i) characterization of the bottom  $\text{ZrO}_2$  layer without the rest of the coating (the top  $\text{ZrO}_2$  layer was expected to have the same properties) and (ii) characterization of the whole coating, using the properties of  $\text{ZrO}_2$  as input quantities. The measurements were performed at the angles of incidence of 55, 60 and 65° in reflection, in the wavelength ( $\lambda$ ) range from 300 to 2000 nm. Below we give n and k at  $\lambda = 550$  nm,  $n_{550}$  and  $k_{550}$ . The optical data were fitted using the WVASE software and an optical model which included the UFG substrate,  $\text{ZrO}_2$  layers represented by the Cauchy oscillator, a W-doped VO $_2$  layer represented by a combination of the Cody-Lorentz oscillator with Lorentz oscillators and a surface roughness layer.

The coating transmittance, T, was measured at a temperature  $T_{\rm m}$  between  $T_{\rm ms}=-10$  °C (semiconducting state well below  $T_{\rm tr}$ ) and  $T_{\rm mm}=70$  °C (metallic state well above  $T_{\rm tr}$ ) using the Agilent CARY 7000 spectrophotometer equipped with an in-house made heat/cool stage. Below we present (i) T at  $\lambda=2500$  nm,  $T_{2500}$ , measured in the whole  $T_{\rm m}$  range in order to evaluate  $T_{\rm tr}$  and (ii) spectroscopic  $T(\lambda)$  measured in the  $\lambda$  range from 300 to 2500 nm at the extremal temperatures  $T_{\rm ms}$  and  $T_{\rm mm}$  in order to evaluate the integral transmittances. The luminous transmittance was calculated as

$$T_{\text{lum}}(T_{\text{m}}) = \frac{\int\limits_{380}^{780} \varphi_{\text{lum}}(\lambda)\varphi_{\text{sol}}(\lambda)T(T_{\text{m}},\lambda)d\lambda}{\int\limits_{380}^{780} \varphi_{\text{lum}}(\lambda)\varphi_{\text{sol}}(\lambda)d\lambda},$$
(1)

where  $\varphi_{\text{lum}}$  is the luminous sensitivity of the human eye and  $\varphi_{\text{Sol}}$  is the sea-level solar irradiance, the solar energy transmittance was calculated as

$$T_{\text{sol}}(T_{\text{m}}) = \frac{\int\limits_{300}^{2500} \varphi_{\text{sol}}(\lambda) T(T_{\text{m}}, \lambda) d\lambda}{\int\limits_{300}^{2500} \varphi_{\text{sol}}(\lambda) d\lambda}$$
 (2)

and their modulations were calculated as

$$\Delta T_{\text{lum}} = T_{\text{lum}}(T_{\text{ms}}) - T_{\text{lum}}(T_{\text{mm}}), \tag{3}$$

$$\Delta T_{\text{sol}} = T_{\text{sol}}(T_{\text{ms}}) - T_{\text{sol}}(T_{\text{mm}}). \tag{4}$$

A homogeneous temperature field has been achieved by supporting the 0.1 mm thick UFG by an underlying 1 mm thick conventional sodalime glass, at a cost of introducing a thin air layer over most of the contact area between both glass layers. Note that the additional interference at this air layer (not included in the optimized coating design which is described in Sec. 3.1 and which leads to an interference maximum of  $T_{\text{lum}}$ ) decreases the measured  $T_{\text{lum}}$  by  $\approx$ 4% according to experiments (shown in [16]) as well as optical modelling (not shown).

The coating color was calculated from the transmittance or similarly measured reflectance [16] for the CIE 1931  $2^{\circ}$  standard observer and the CIE daylight illuminant D65.

The cross-sectional micrograph of the broken and ion-polished multilayered coating prepared in the large-scale roll-to-roll device at the FEP was acquired by scanning electron microscopy (SEM) using the Hitachi SU-70 instrument (incident beam energy of 5 keV). The room-temperature (25 °C) crystal structure of the same coating was investigated by X-ray diffraction (XRD) using the PANalytical X'Pert PRO instrument working with a CuK $\alpha$  (40 kV, 40 mA) radiation at a glancing incidence of  $1^{\circ}$ .

The W content in the metal sublattice of the  $V_{0.984}W_{0.016}O_2$ , i.e.  $1.6\pm0.6$  at.%, thermochromic (TC) layer prepared in the laboratory-scale device at the UWB was measured on a dedicated 290 nm thick layer (using the same substrate) in the aforementioned scanning electron microscope SU-70 using wave-dispersive spectroscopy (Magnaray, Thermo Scientific) at a primary electron energy of 7 keV.

#### 3. Results and discussion

#### 3.1. Coating design

While the coating design used has been explained and experimentally verified in the laboratory-scale device (UWB) previously [25], the cross-section SEM image shown in Fig. 3a confirms its successful realization in the large-scale roll-to-roll device (FEP). The roles of individual layers and their refractive indices obtained in the latter device are shown in Fig. 3b. As indicated by the formula ZrO2/W-doped VO2/ZrO2, an important part of the coating design are ZrO2 antireflection (AR) layers both below (thickness  $h_{\rm b}$ ) and above (thickness  $h_{\rm t}$ ) the TC layer (thickness h = 71 nm (UWB) or 69 nm (FEP)). The deposition protocol described in Sec. 2.1 led to well densified stoichiometric ZrO2 characterized by  $n_{550} = 2.09$  (UWB) or even 2.19 (FEP) and to W-doped VO<sub>2</sub> characterized by  $n_{550}=2.82$  (UWB) or  $n_{550}=2.73$  (FEP). The corresponding  $k_{550}$  values on the order of at most  $10^{-3}$  (ZrO<sub>2</sub>) and  $\approx 0.4-0.5$ (VO<sub>2</sub>) are neglected in the considerations below. This makes  $n_{550}$  of the AR layers very close to the geometric mean of those of the TC layer and the glass (bottom AR layer) and sufficiently close to the geometric mean of those of the TC layer and the air (top AR layer), fulfilling the condition for AR layers shifting the upper envelope of the interference curve  $T(\lambda)$ as close to 100% as possible. Further advantages of ZrO2 include (i) easily achievable crystallinity (example in Fig. 4) at the deposition temperature used, which gives the bottom AR layer a second role of structure template improving the crystallinity of the TC layer [12,26], and (ii) high hardness (for an oxide), which gives the top AR layer a second role of a mechanical protection of the TC layer.

The maximization of  $T_{\text{lum}}$  requires not only as high upper envelope of  $T(\lambda)$  as possible but also positioning of one of the interference maxima which touch this upper envelope close to  $\lambda=550$  nm. While the former is achieved by proper  $n_{550}$  of the AR layers, the latter is achieved by proper thickness of the AR layers. The first approximation can be given by treating each AR layer separately and once again neglecting  $k_{550}$ , leading to the well known formulas  $h_{\text{b,t}}=\lambda/[4n_{550}]$  (quarter-wavelength layers),  $3\lambda/[4n_{550}]$  (three-quarter wavelength layers), etc. Precise calculations (e.g. not neglecting k) of integral  $T_{\text{lum}}$  (shown in [25]) yield slightly different numbers, e.g.  $n_{550}=2.15$  leads to first-order maxima of  $T_{\text{lum}}$  around  $h_{\text{b,t}}=45$  nm (less than  $550/[4\times2.15]=64$  nm) and second-order maxima of  $T_{\text{lum}}$  around  $h_{\text{b,t}}=180$  nm (less than  $3\times550/[4\times2.15]=192$  nm). The ideal  $h_{\text{b,t}}$  values are almost independent of h, and they are approximately inversely proportional to  $n_{550}$  in order to fix the optical path length ( $180\times2.15$ ).

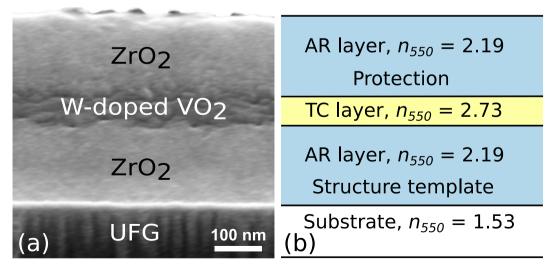


Fig. 3. (a) Cross-section SEM image of the  $ZrO_2/W$ -doped  $VO_2/ZrO_2$  coating on ultrathin flexible glass (UFG) prepared using the large-scale roll-to-roll device. (b) Schematic diagram of the coating with characterization of the functions of the individual layers and their refractive indices at the wavelength of 550 nm,  $n_{550}$ , measured at  $T_m = 23$  °C. Here, AR stands for the antireflection layers and TC stands for the thermochromic layer.

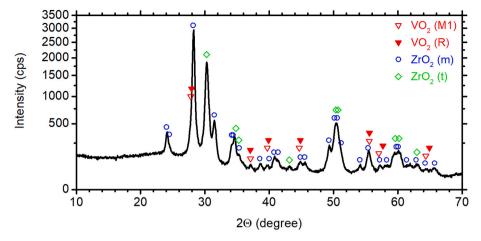


Fig. 4. X-ray diffraction patterns taken at  $T_m = 25$  °C from the ZrO<sub>2</sub> (167 nm)/W-doped VO<sub>2</sub> (69 nm)/ZrO<sub>2</sub> (167 nm) coating on ultrathin flexible glass prepared using the large-scale roll-to-roll device. The main diffraction peaks of VO<sub>2</sub> (R), VO<sub>2</sub> (M1), ZrO<sub>2</sub> (m) and ZrO<sub>2</sub> (t) are marked.

Next, it is necessary to consider that the criterion of success is simultaneous optimization of  $T_{lum}$  and  $\Delta T_{sol}$ . On the one hand, the firstorder maximum of  $T(\lambda)$  in the visible does not lead to anything special in the infrared where most of the energy saving is required to take place. Consequently, the first-order AR layers lead to high  $T_{lum}$  but relatively low  $\Delta T_{\text{sol}}$ . On the other hand, the second-order maximum of  $T(\lambda)$  in the visible leads to a first-order maximum of  $T(\lambda)$  in the infrared (example in Fig. 5), increasing the potential for T modulation in this  $\lambda$  range. Consequently, the second-order AR layers lead to about the same  $T_{lum}$  as the first-order AR layers but to a much higher  $\Delta T_{\rm sol}$  [25]. Indeed, the thicknesses of the AR layers deposited,  $h_{\rm b}=172~{\rm nm}$  and  $h_{\rm t}=178~{\rm nm}$ (UWB) or  $h_b = h_t = 167$  nm (FEP), almost exactly lead to second-order maxima of  $T_{\text{lum}}$ : [180 × 2.15]/[(172 or 178) × 2.09] = 104 or 108% (UWB) and  $[180 \times 2.15]/[167 \times 2.19] = 106\%$  (FEP). Note that the total thickness of the latter coating as measured by spectroscopic ellipsometry,  $h_b + h + h_t = 167 + 69 + 167 = 403$  nm, very well

corresponds to the cross-section SEM image in Fig. 3a. Following the design even more precisely is desired for industrial production, but beyond the aim to demonstrate the transferability to the large-scale device in itself.

#### 3.2. Coating structure and properties

The XRD pattern of the coating prepared in the large-scale roll-to-roll device (FEP) is shown in Fig. 4. First and most importantly, the figure shows that the only crystalline phases identified in the TC layer are the desired thermochromic polymorphs  $VO_2(M1)$  (PDF#04-003-2035 [27]) and  $VO_2(R)$  (PDF#01-073-2362). There is not any contribution of metastable non-thermochromic polymorphs such as  $VO_2(B)$  or  $VO_2(P)$ , and there is not any contribution of non-thermochromic phases with slightly different stoichiometries such as  $VO_2(C)$ 0, the thermodynamically preferred phase under O-rich conditions).

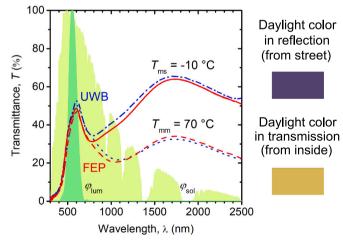
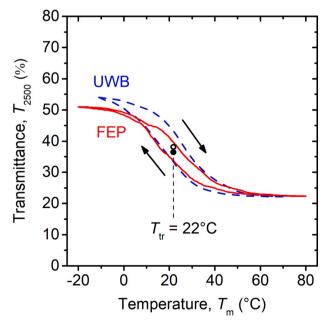


Fig. 5. The transmittance as a function of the wavelength for the ZrO<sub>2</sub> (167 nm)/W-doped VO<sub>2</sub> (69 nm)/ZrO<sub>2</sub> (167 nm) coating prepared using the large-scale roll-to-roll device (FEP, solid and dashed line) and for the ZrO<sub>2</sub> (172 nm)/V<sub>0.984</sub>W<sub>0.016</sub>O<sub>2</sub> (71 nm)/ZrO<sub>2</sub> (178 nm) coating prepared using the laboratory-scale device (UWB, dash-dotted and dotted line). During the measurements at the temperatures  $T_{\rm ms}=-10$  °C (significantly below  $T_{\rm tr}$ ) and  $T_{\rm mm}=70$  °C (significantly above  $T_{\rm tr}$ ), the samples on ultrathin glass were supported by an underlying 1 mm thick soda-lime glass. The contours of the shaded areas represent the luminous sensitivity of the human eye ( $\varphi_{\rm lum}$ ) and the sea-level solar irradiance spectrum at an air mass of 1.5 ( $\varphi_{\rm sol}$ ), normalized to maxima of 100%. The daylight colors in transmission and reflection calculated for the UWB coating are presented.



**Fig. 6.** Temperature  $(T_{\rm m})$  dependence of the transmittance  $T_{2500}$  at 2500 nm for the ZrO<sub>2</sub> (167 nm)/W-doped VO<sub>2</sub> (69 nm)/ZrO<sub>2</sub> (167 nm) coating prepared using the large-scale roll-to-roll device (FEP) and the ZrO<sub>2</sub> (172 nm)/V<sub>0.984</sub>W<sub>0.016</sub>O<sub>2</sub> (71 nm)/ZrO<sub>2</sub> (178 nm) coating prepared using the laboratory-scale device (UWB), see Fig. 5. The transition temperature  $T_{\rm tr}=22$  °C is marked.

#### Table 3

Thermochromic properties of the ZrO<sub>2</sub> (167 nm)/W-doped VO<sub>2</sub> (69 nm)/ZrO<sub>2</sub> (167 nm) coating and the ZrO<sub>2</sub> (172 nm)/ $V_{0.984}W_{0.016}O_2$  (71 nm)/ZrO<sub>2</sub> (178 nm) coating deposited on ultrathin flexible glass (UFG) using the large-scale roll-to-roll device (FEP) and the laboratory-scale device (UWB), respectively. The measured T values are underestimated by  $\approx 4\%$  owing to the effect of the very thin air layer arising between the UFG substrate and an underlying supporting 1 mm thick soda-lime glass used during the measurements (see Section 2.2).

Device	$T_{\text{lum}} (T_{\text{ms}})$	$T_{\text{lum}} (T_{\text{mm}})$	$\Delta T_{ m lum}$	$T_{\rm sol} (T_{\rm ms})$	$T_{\rm sol} (T_{\rm mm})$	$\Delta T_{ m sol}$
	(%)	(%)	(%)	(%)	(%)	(%)
FEP UWB	43.2 45.7	40.5 42.2	2.7 3.5	37.0 39.6	28.3 30.0	8.7 9.6

Second, the simultaneous presence of  $VO_2(M1)$  and  $VO_2(R)$  strongly indicates that the doping by W has been successful and that the transition temperature is close to room temperature at which the measurement took place (see Fig. 6 for more details). Third, the figure confirms that the AR layers are well crystalline, see the strong narrow peaks corresponding to monoclinic  $ZrO_2$  ( $ZrO_2(m)$ ; PDF#04-013-6875) with a contribution of tetragonal  $ZrO_2$  (PDF#01-081-1544 valid for  $ZrO_{1.95}$ ). This supports the aforementioned second role of the bottom AR layer (structure template which improves the crystallinity of the TC layer).

The success of the transfer from the laboratory-scale device (UWB) to the large-scale roll-to-roll device (FEP) is quantified by comparison of the performance of both multilayered coatings in terms of spectroscopic  $T(\lambda)$  in Fig. 5, integral quantities calculated using  $T(\lambda)$  in Table 3 and  $T_{tr}$ in Fig. 6. All interference curves  $T(\lambda)$  shown in Fig. 5 are characteristic of the design explained in Sec. 3.1: see the first-order maximum of  $T(\lambda)$  in the infrared and the second-order maximum of  $T(\lambda)$  in the visible. The strongly temperature-dependent maximum of  $T(\lambda)$  in the infrared is largely responsible for the relatively high  $\Delta T_{\rm sol}$  approaching 10% as shown in Table 3. The almost temperature-independent maximum of T ( $\lambda$ ) in the visible is responsible for the relatively high  $T_{\text{lum}}$  of 45–50% as also shown in Table 3, taking into account (Sec. 2.2) that the  $T_{lum}$  values in Table 3 are by  $\approx$ 4% lower than the  $T_{lum}$  values which truly characterize the coatings but which could not be directly measured because of the thin air layer between the UFG substrate and the underlying supporting glass. The temperature independence of  $T_{\text{lum}}$  ( $\Delta T_{\text{lum}}$  shown in Table 3 of only ≈3%) constitutes an important advantage of the presented coatings over other solutions where the energy saving takes place primarily in the visible. The complicated dispersion of optical constants leads to a yellowish color in transmission and bluish color in reflection (visualized in Fig. 5; the fact that the coating color is almost independent of the temperature is presented in detail in [16]).

Most importantly, it can be seen that the transfer to the large-scale device led not only to qualitatively the same multilayered structure (Fig. 3) and crystal structure (Fig. 4), but also to quantitatively almost the same properties. Fig. 5 shows that the interference curves  $T(\lambda)$ exhibited by both coatings are very similar, both horizontally (in agreement with similar optical path lengths in AR layers given in Sec. 3.1) and vertically (in agreement with similar h values of 69–71 nm). A case can be made that the FEP coating exhibits not only  $\Delta T_{\rm sol}$  by  $\approx 1\%$ lower (which is consistent with slightly lower h) but also  $T(\lambda)$  in the visible and in turn  $T_{lum}$  by  $\approx$ 2% lower (which is contrary to slightly lower h). However, these small differences are within the usual dependence of  $k_{550}$  of VO<sub>2</sub> on the exact deposition conditions and on the probable consequent tiny changes in the O content (an important open question in this field, beyond the scope of the present paper). In parallel, Fig. 6 shows that the doping of VO<sub>2</sub> by W has been equally successful in both cases, leading to the same  $T_{\rm tr}$  (as defined by a half of the total  $T_{2500}$ change, averaged over both branches of the hysteresis loop) of 22 °C. The occasionally reported harmful effect of W on the thermochromic performance of VO<sub>2</sub> prepared using e.g. the sol-gel method [28] or the hydrothermal synthesis [29] has not been observed using any of the two presented deposition protocols based on the controlled reactive HiPIMS.

#### 4. Conclusions

There is only one sputter technique of VO2-based thermochromic coatings for energy-saving smart windows which previously led to a combination of all the key achievements at least on the laboratory scale: low surface temperature (330 °C) of conventional glass or flexible glass substrates without any substrate bias voltage and post-deposition annealing, and low thermochromic transition temperature down to pprox20 °C at a competitive luminous transmittance and modulation of the solar energy transmittance [16]. We have carried out a successful transfer of this technique based on controlled reactive HiPIMS to a largescale (300 mm × 20 m substrates) roll-to-roll deposition device. Using the same ultrathin flexible glass substrate and almost the same substrate temperature (close to 350 °C), we have used this large-scale device to prepare qualitatively the same ZrO<sub>2</sub>/W-doped VO<sub>2</sub>/ZrO<sub>2</sub> coating which has been prepared previously on the laboratory scale, including (i) the desired crystal structure of individual layers, (ii) almost the same optical path lengths in the second-order ZrO2 antireflection layers and (iii) a tungsten doping level leading to exactly the same thermochromic transition temperature.

We have confirmed that the coating consequently exhibits almost the same values of luminous transmittance and modulation of the solar energy transmittance. The results constitute an important step toward industrialization of coatings prepared by controlled reactive HiPIMS in general and of energy-saving thermochromic coatings in particular.

#### CRediT authorship contribution statement

Jiří Rezek: Investigation, Data curation, Visualization. Jolanta Szelwicka: Investigation, Data curation. Jaroslav Vlček: Conceptualization, Methodology, Writing - original draft, Writing - review & editing. Radomír Čerstvý: Investigation. Jiří Houška: Writing - original draft. Matthias Fahland: Conceptualization. John Fahlteich: Conceptualization.

#### **Declaration of competing interest**

The authors declare that they have no known competing financial interests or personal relationships that could have appeared to influence the work reported in this paper.

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